


<b>Search Notes</b>  	<b>Application/Control No.</b>  10566216	<b>Applicant(s)/Patent Under Reexamination</b>  SHIMIZU ET AL.
	<b>Examiner</b>  LILIANA CERULLO	<b>Art Unit</b>  2629

SEARCHED			
Class	Subclass	Date	Examiner
345	82-84, 106	10/27/2008	LC
345	82-84	3/12/2009	LC
345	82-84, 106, 105, 204, 690, 101	9/2/2009	LC
315	309, 169.3	9/2/2009	LC

SEARCH NOTES		
Search Notes	Date	Examiner
See EAST search history	10/27/2008	LC
See EAST search history	3/12/2009	LC
See EAST search history	9/2/2009	LC
Consulted with Primary Examiner Jimmy Nguyen regarding field of search	9/2/2009	LC
Google Search, IEEE search	9/2/2009	LC

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
345	83, 690	9/2/2009	LC
315	309, 169.3	9/2/2009	LC

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